



Prof. Dr. Steffen Härtel: www.scian.cl / www.cimt.cl / www.cens.cl

Laboratory for Scientific Image Analysis (SCIAN-Lab)
Centro de Informática Médica y Telemedicina (CIMT)
Centro Nacional en Sistemas de Información en Salud (CENS)
Biomedical Neuroscience Institute (BNI)
Institute of Biomedical Sciences (ICBM)
Anatomy and Developmental Biology Program
Escuela de Postgrado
Facultad de Medicina, Universidad de Chile

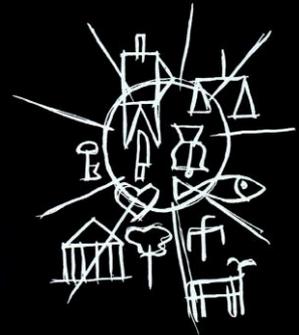
Welcome



Joaquín Torres García 1874-1949



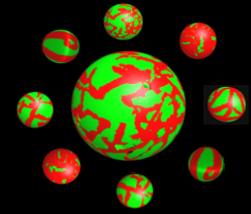
Richard Feynman (1918-1988)



María Goeppert-Mayer 1906-1972



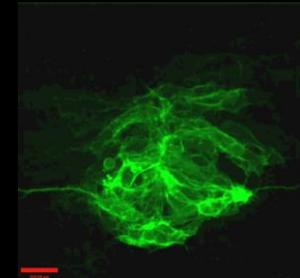
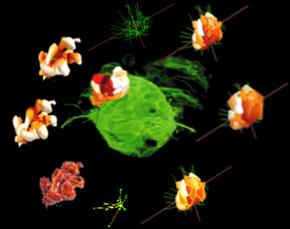
Mats Gustafson 2006 - 2011



René Descartes (1596-1650)



Ernst Abbe 1840- 2005



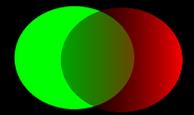
E Betzig



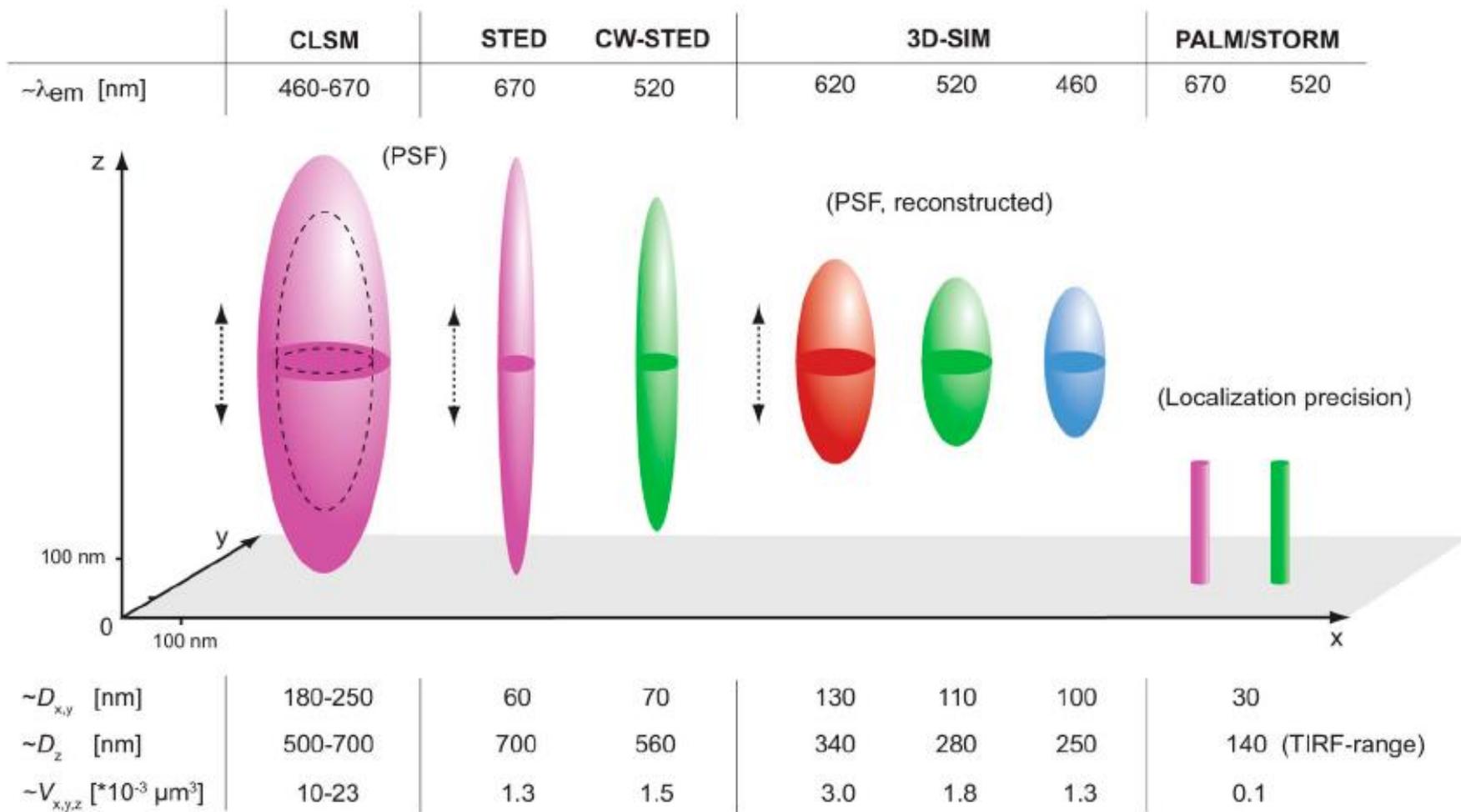
S Hell



W Moerner

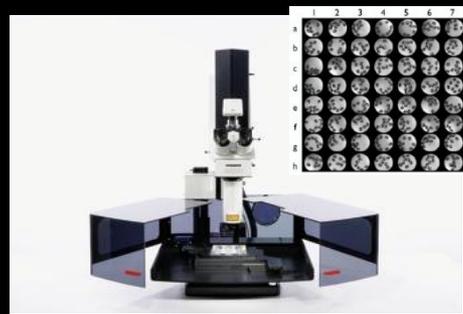
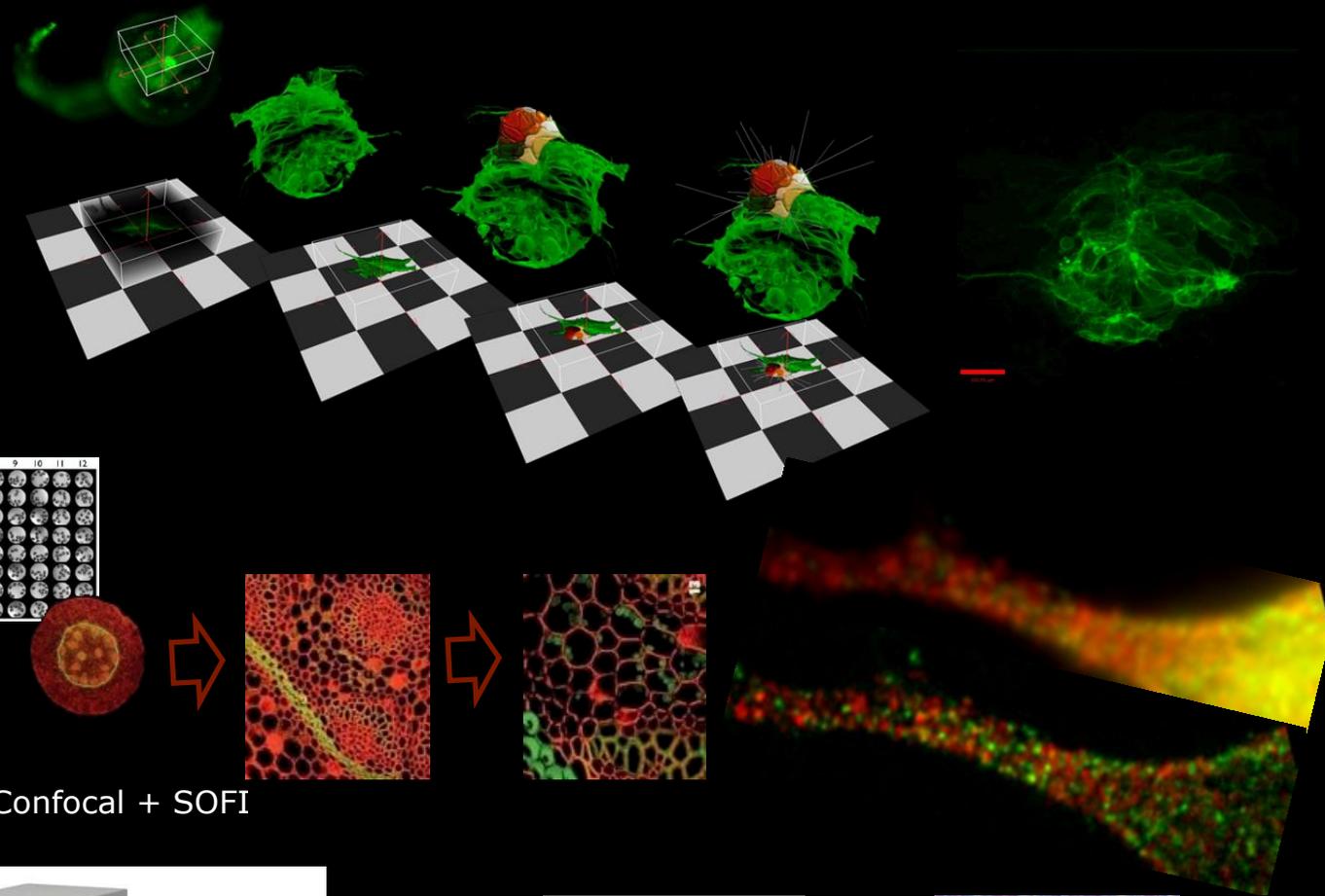


|-> PSF overview

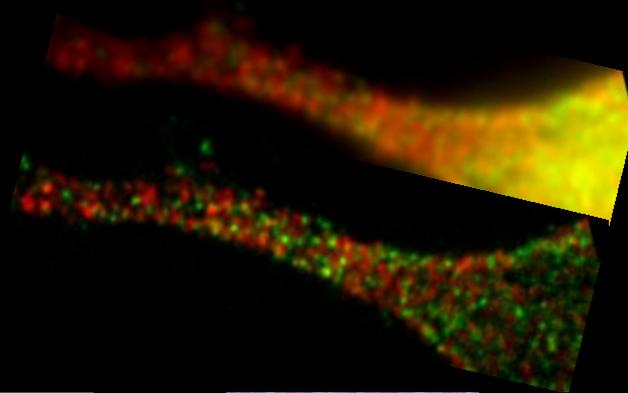




Perkin Elmer Spinning Disk



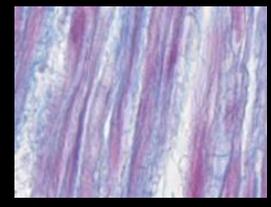
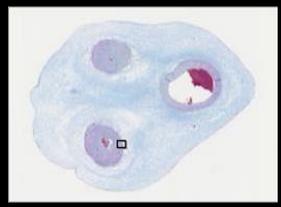
Leica TCS LSI: Super Zoom Confocal + SOFI



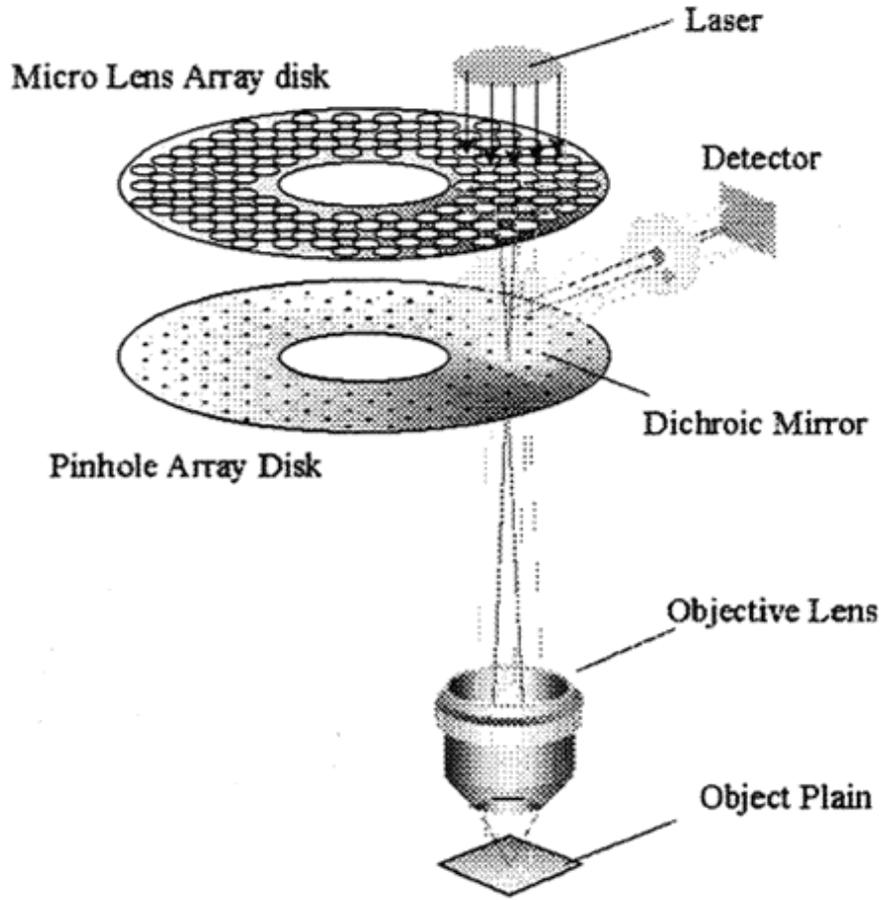
TB Data per Experiment



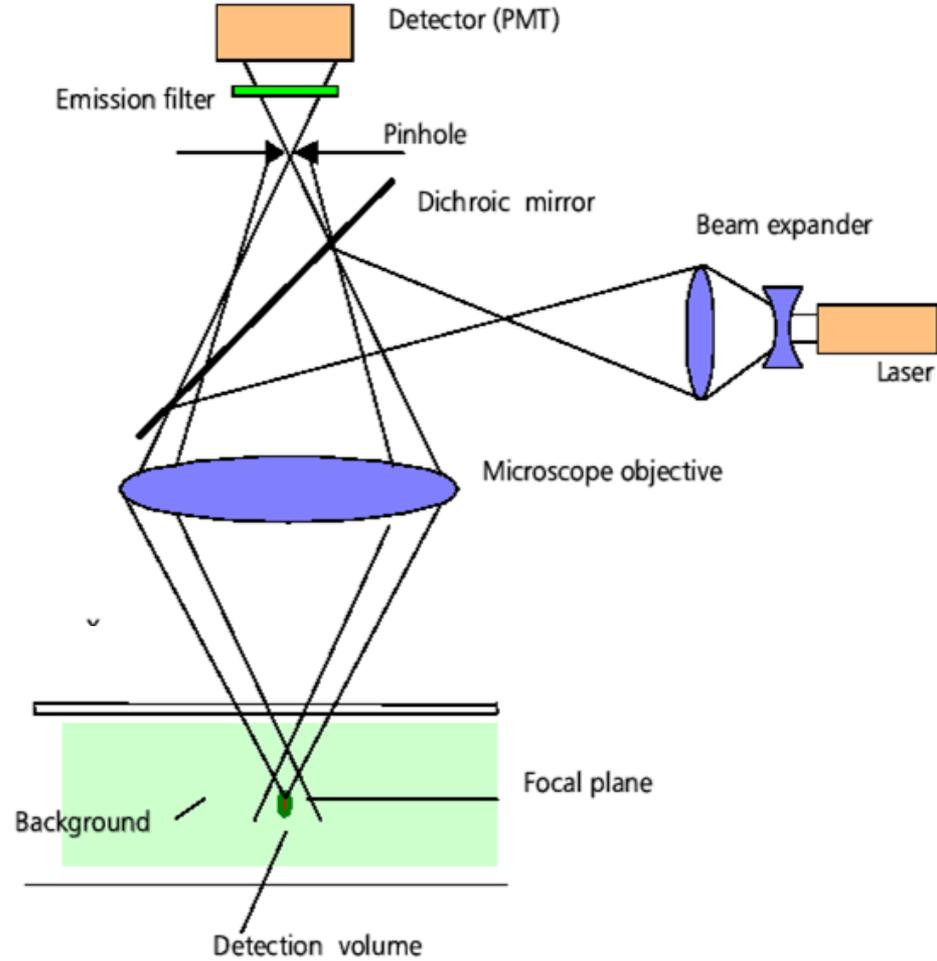
NanoZoomer: Tissue Imaging



|-> Spinning Disk



spinning disk



confocal

Yokogawa Spinning Disk Unit Optical Configuration

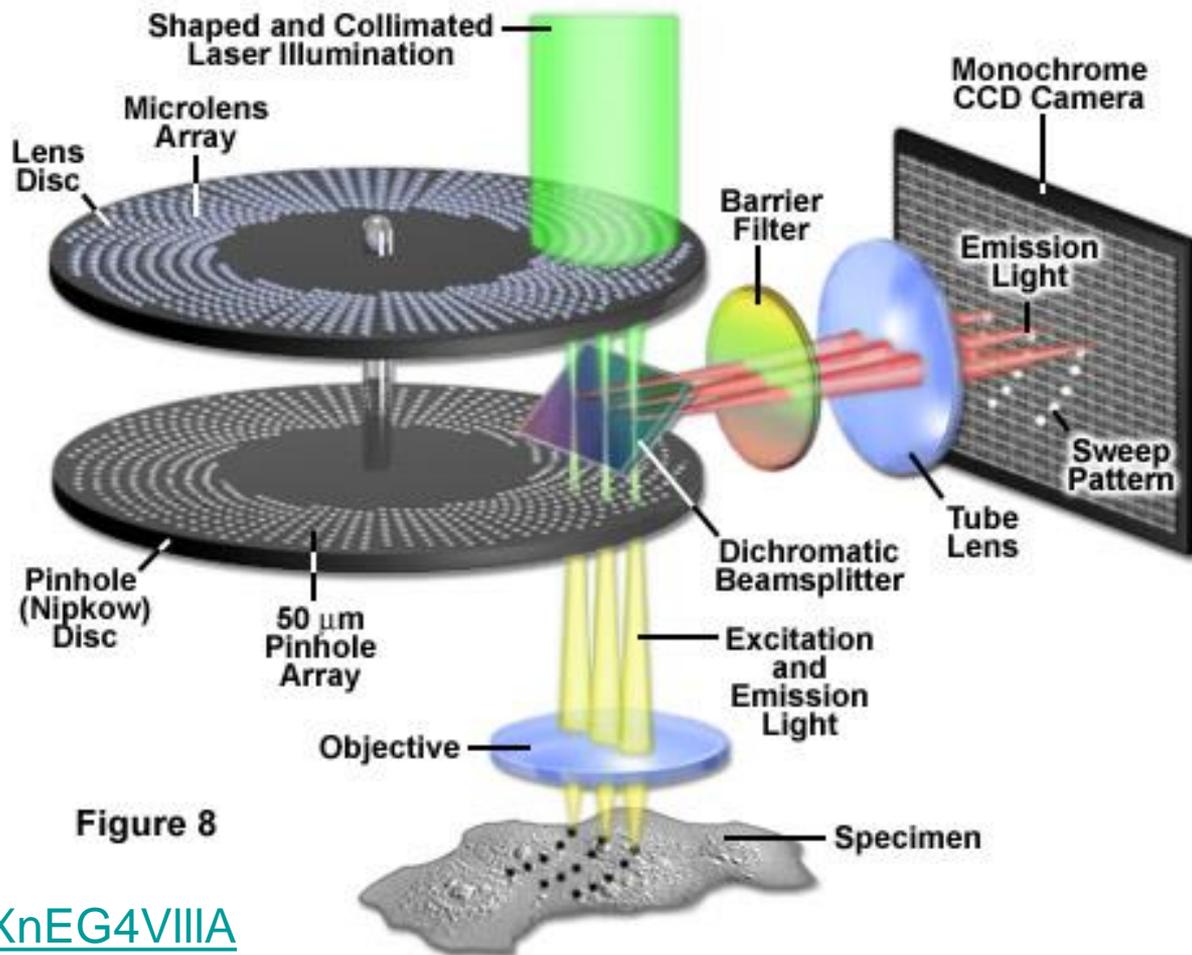
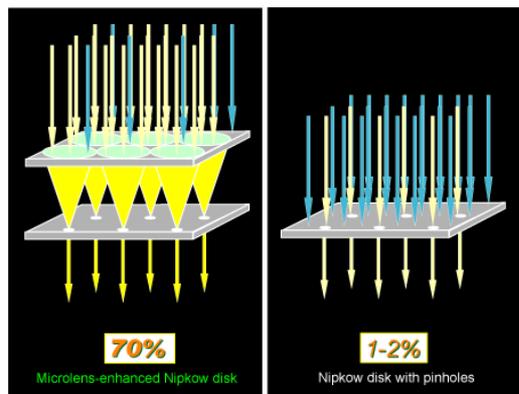
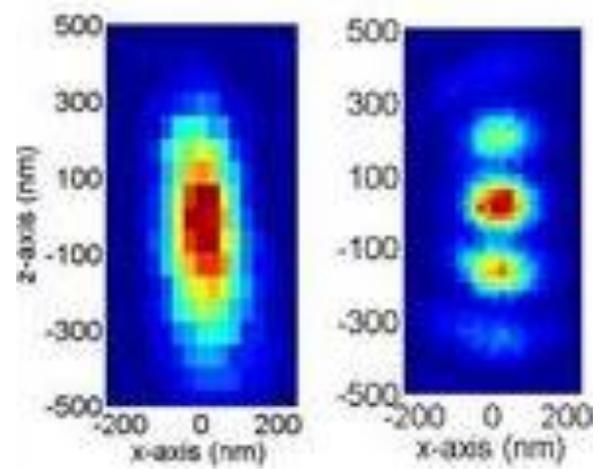
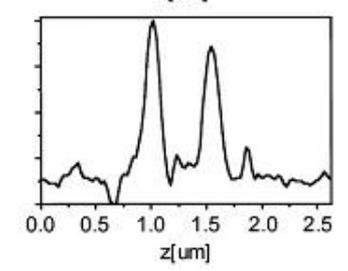
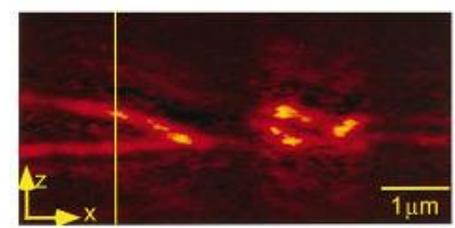
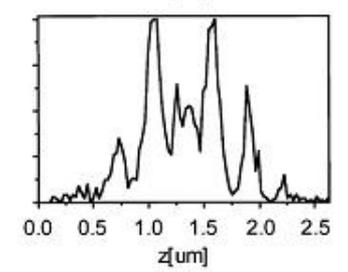
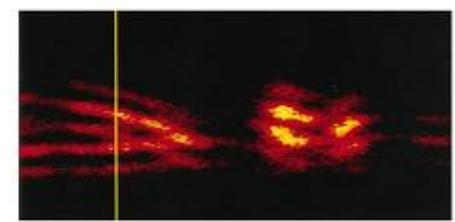
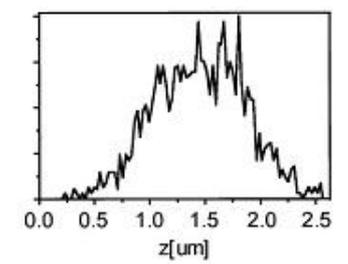
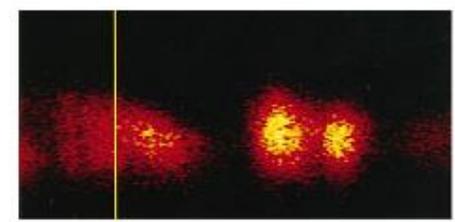
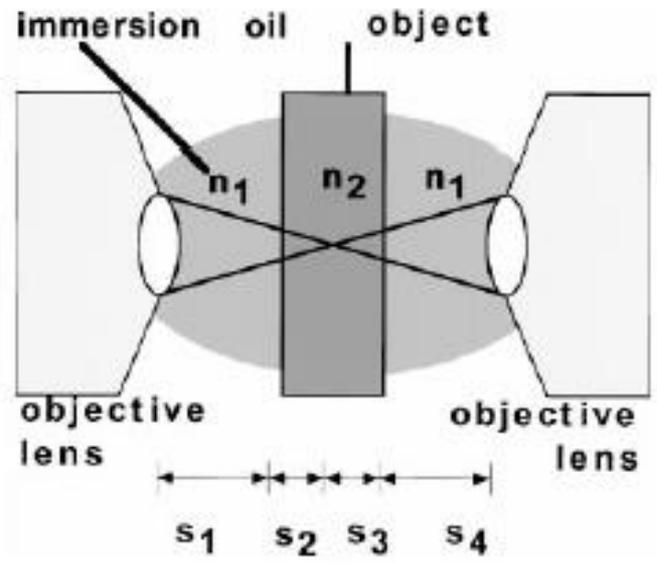


Figure 8



| -> 4π Microscopy



| -> confocal

| -> 4π

4Pi-Confocal Imaging in Fixed Biological Specimens

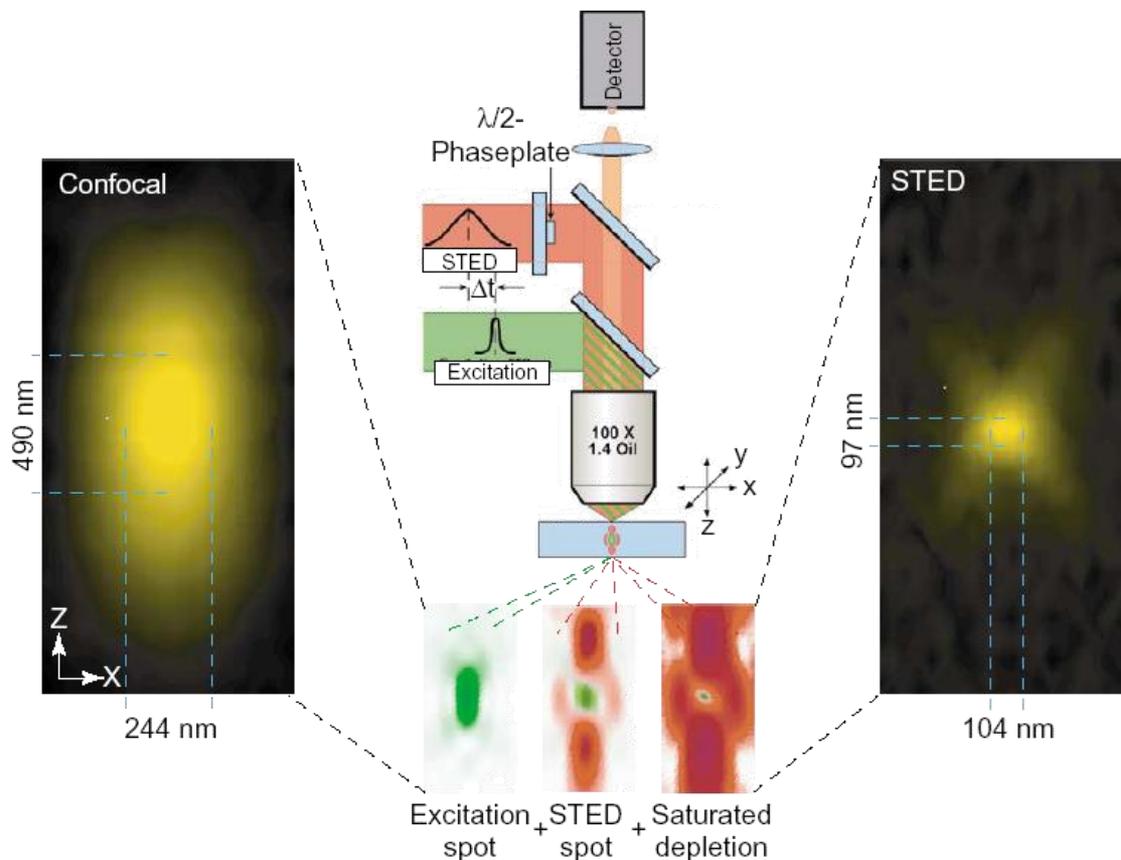
Martin Schrader,* Karsten Bahlmann,* Günter Giese,# and Stefan W. Hell*
 Biophysical Journal Volume 75 October 1998 1659-1668

STED Microscopy

Stimulated

Emission

Depletion



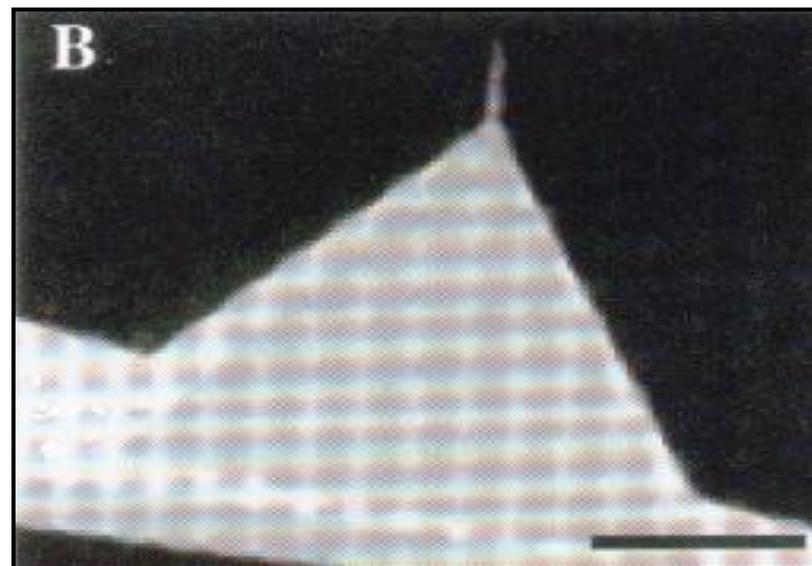
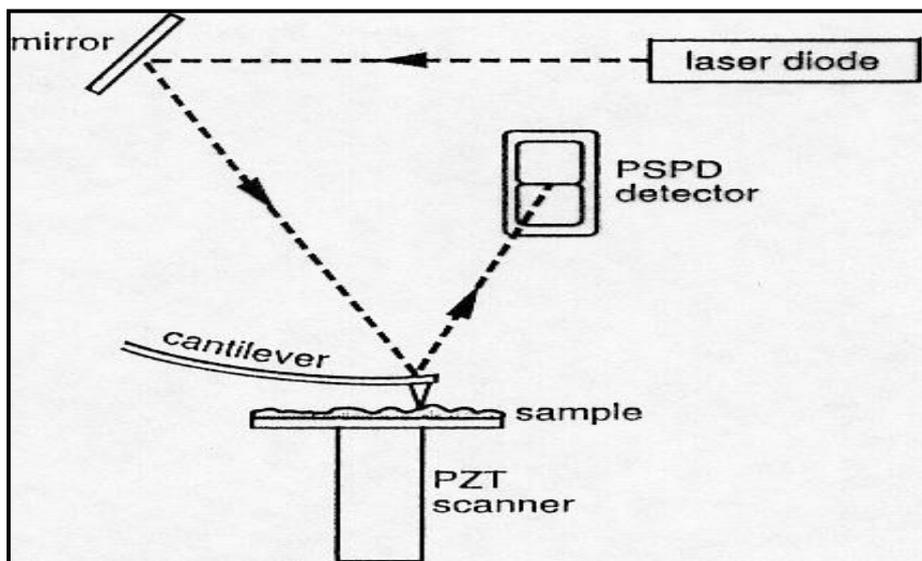
Concepts for nanoscale resolution in fluorescence microscopy

Stefan W Hell*, Marcus Dyba¹ and Stefan Jakobs²

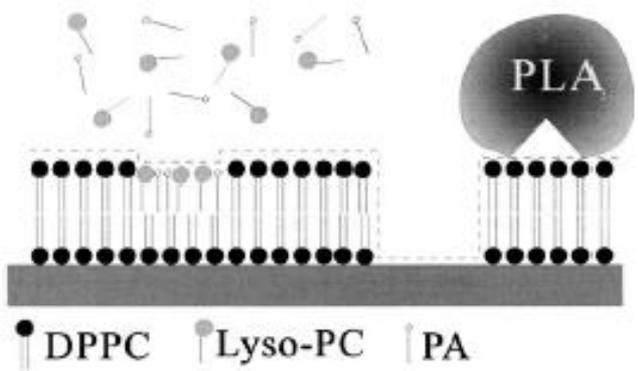
Current Opinion in Neurobiology 2004, 14:599-609

AFM allows the investigation of structural and functional properties of biomolecules in liquid environments, by a unique combination of :

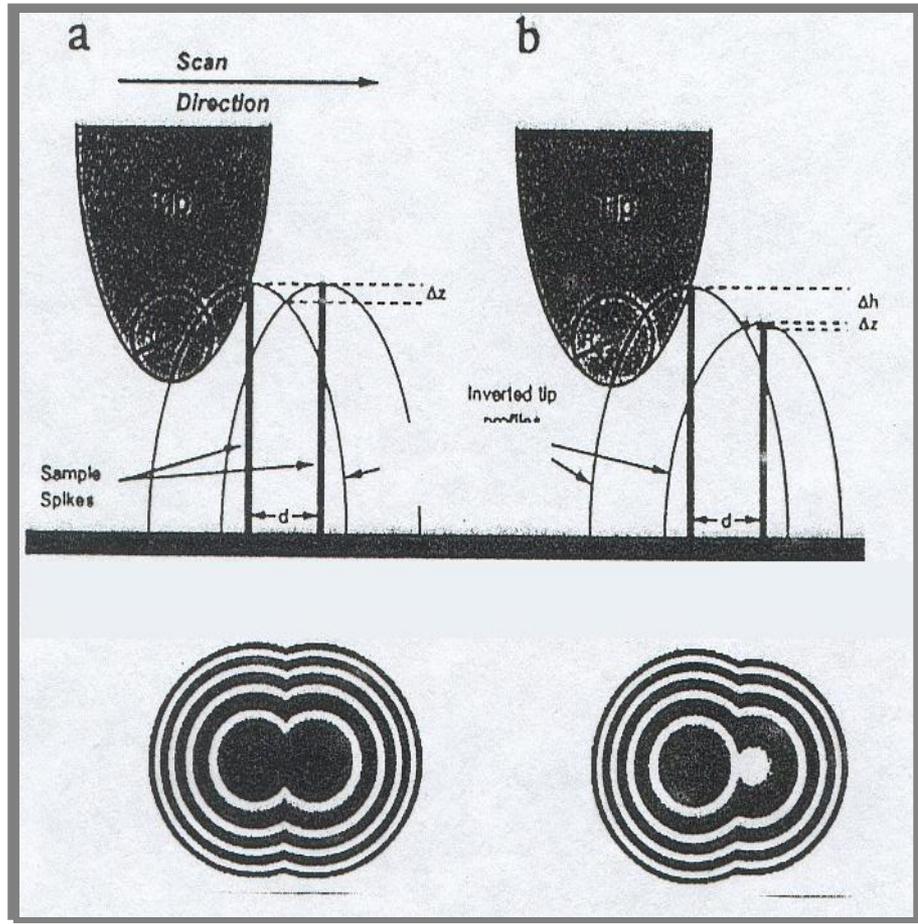
- ***subnanometer*** spatial resolution
- ***millisecond*** temporal resolution
- ***piconewton*** force sensitivity



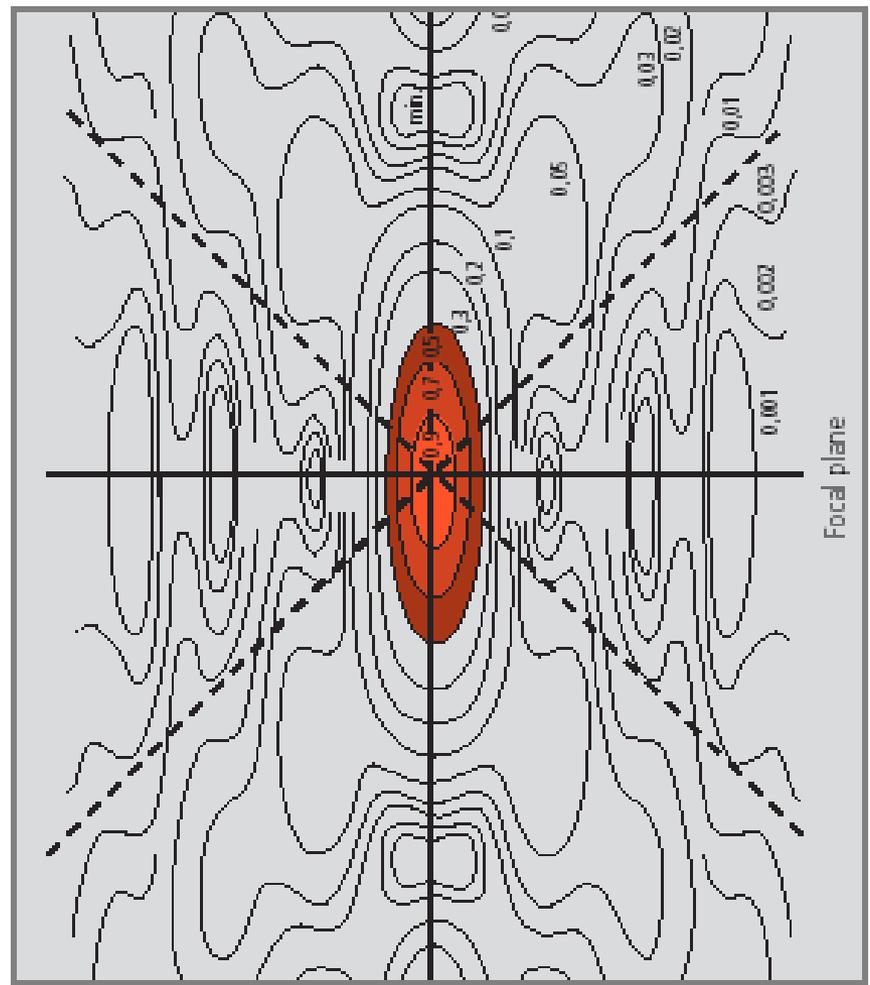
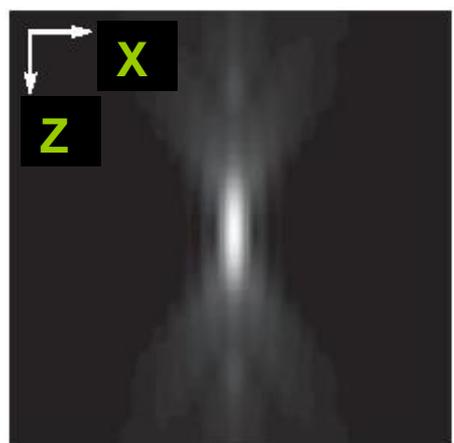
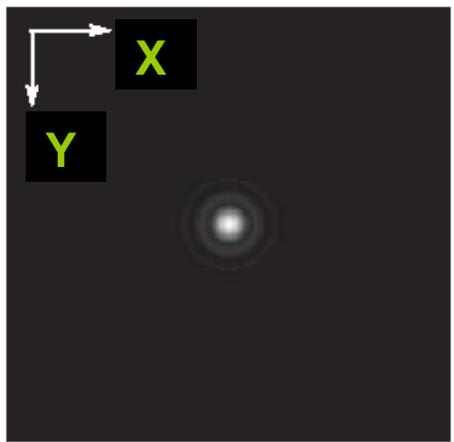
| -> Atomic Force Microscopy

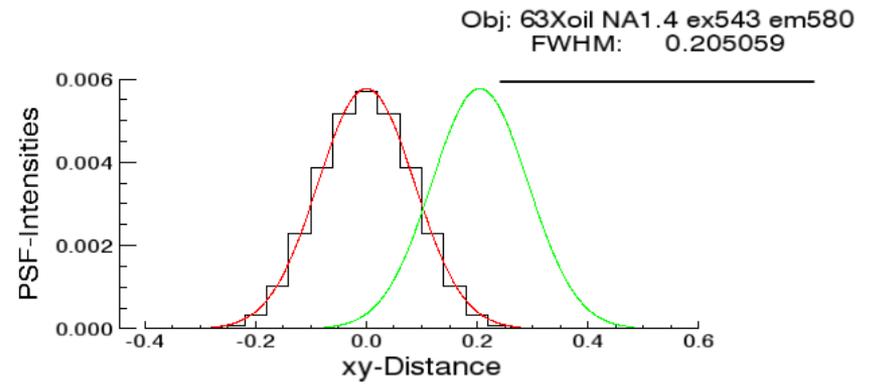
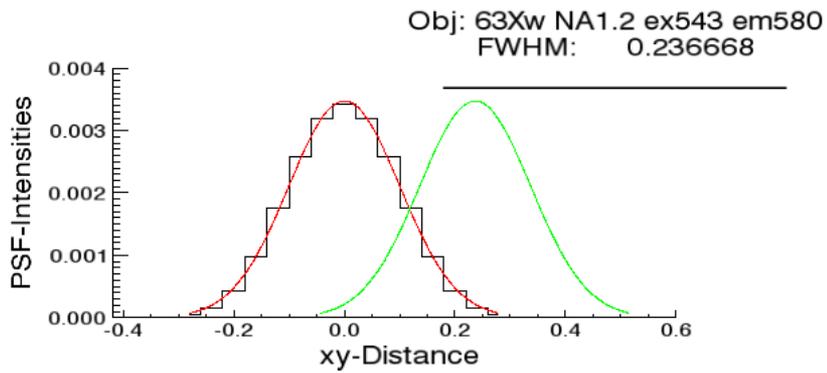
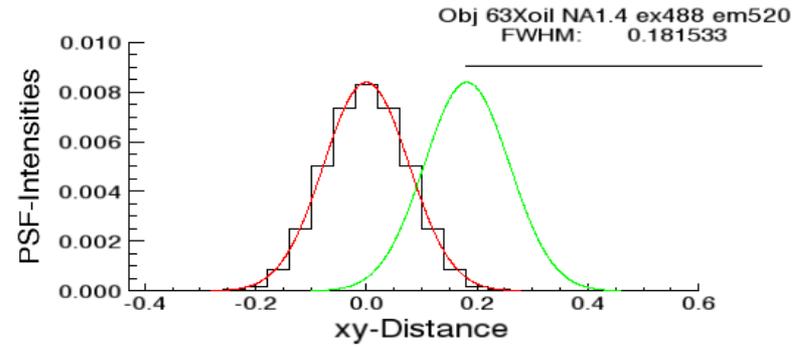
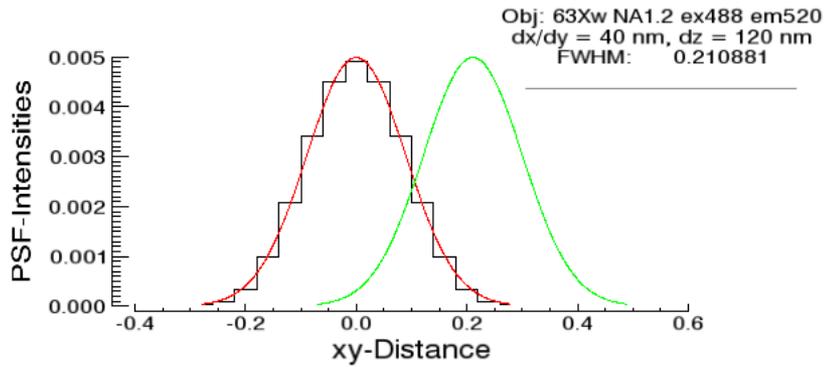


M Grandbois et al. (1998) Biophys J.

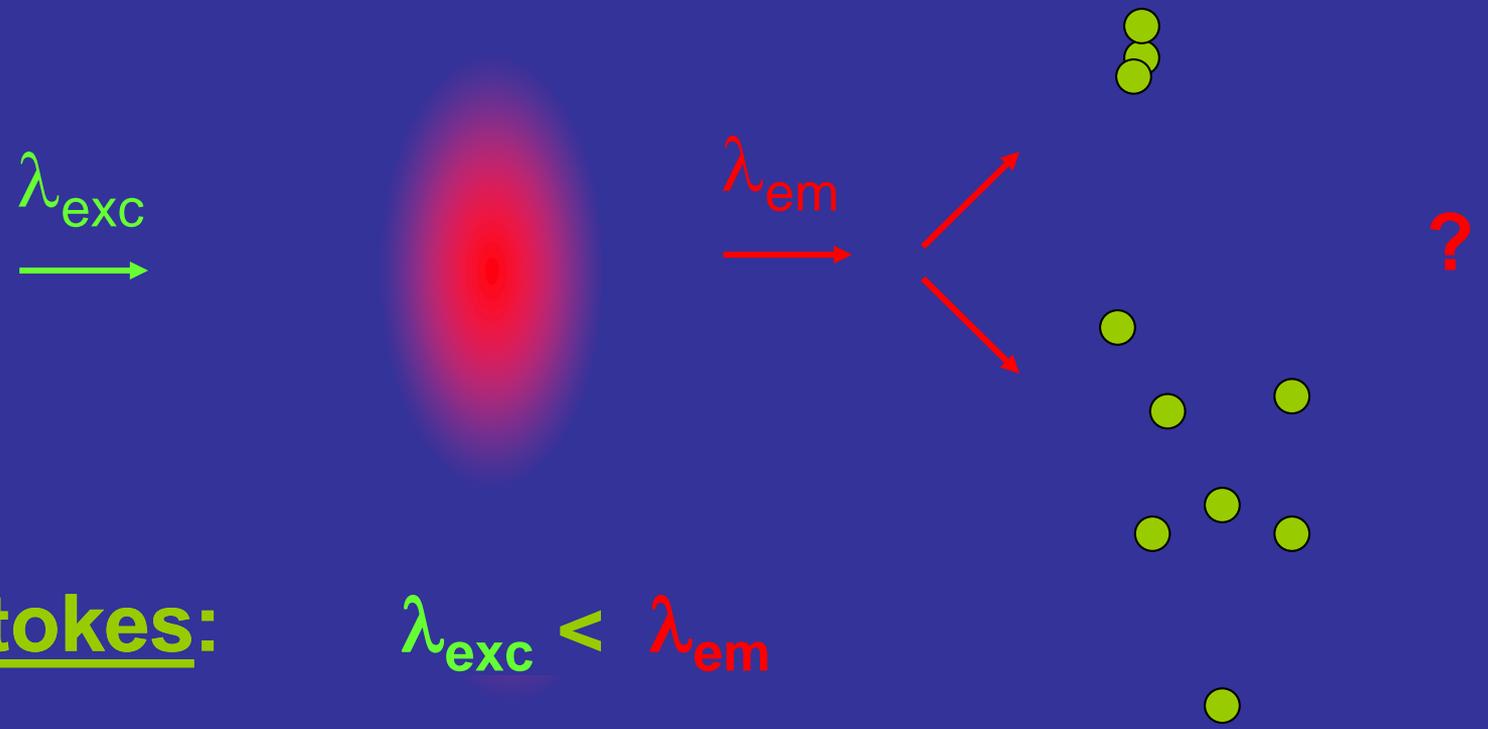


| -> PSF





| -> Convolution



|-> Convolution

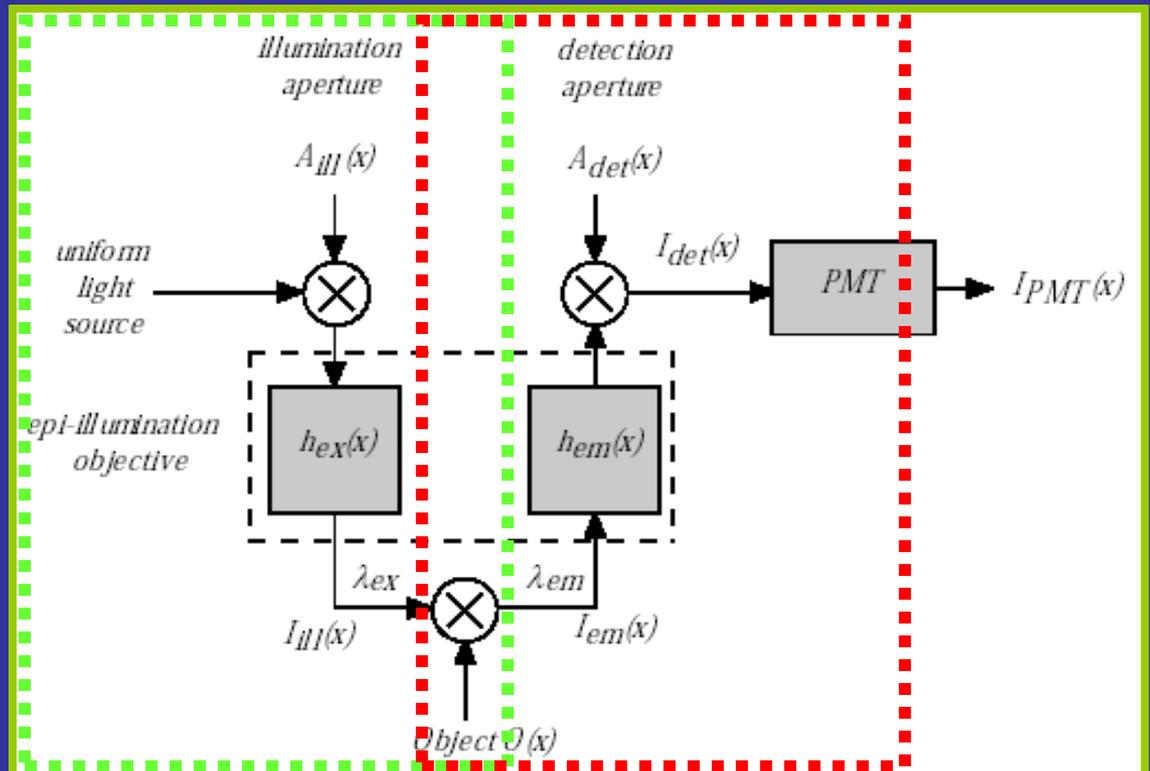
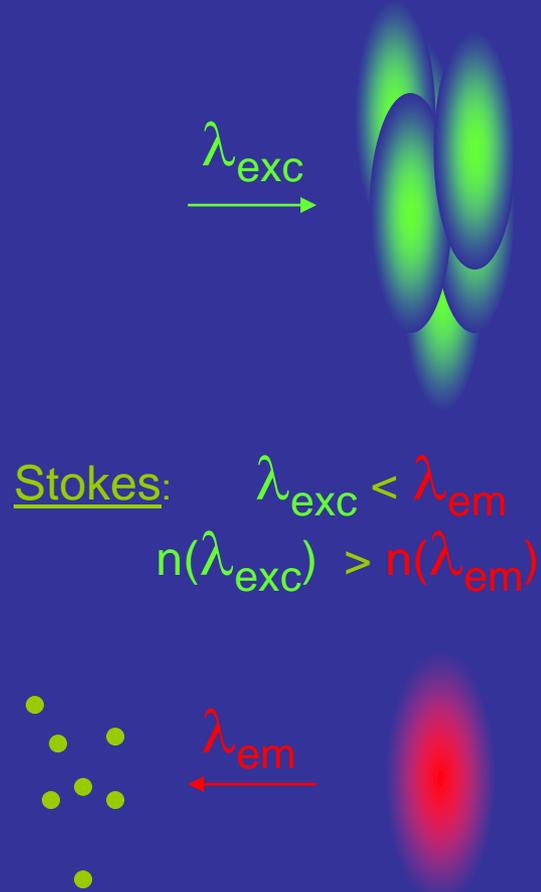
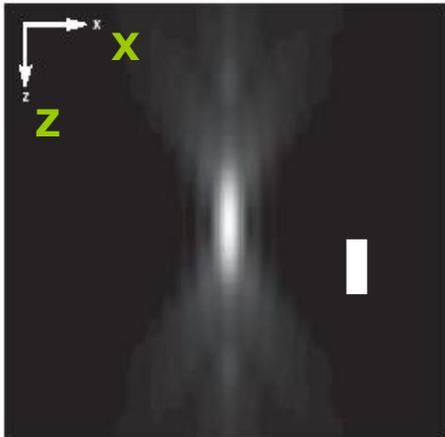


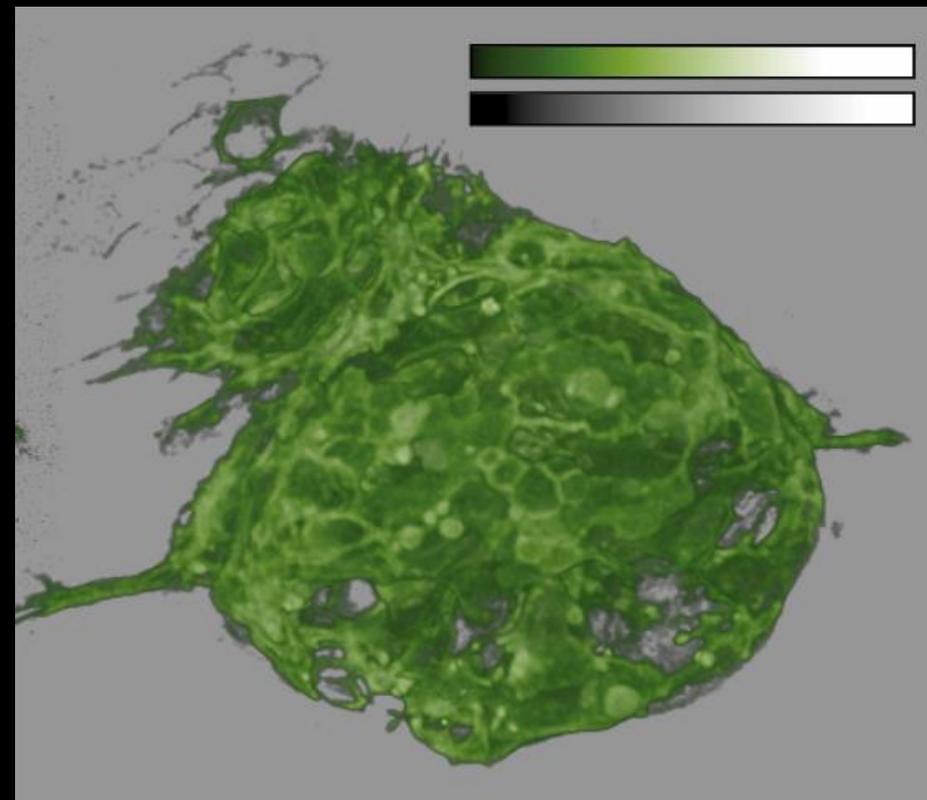
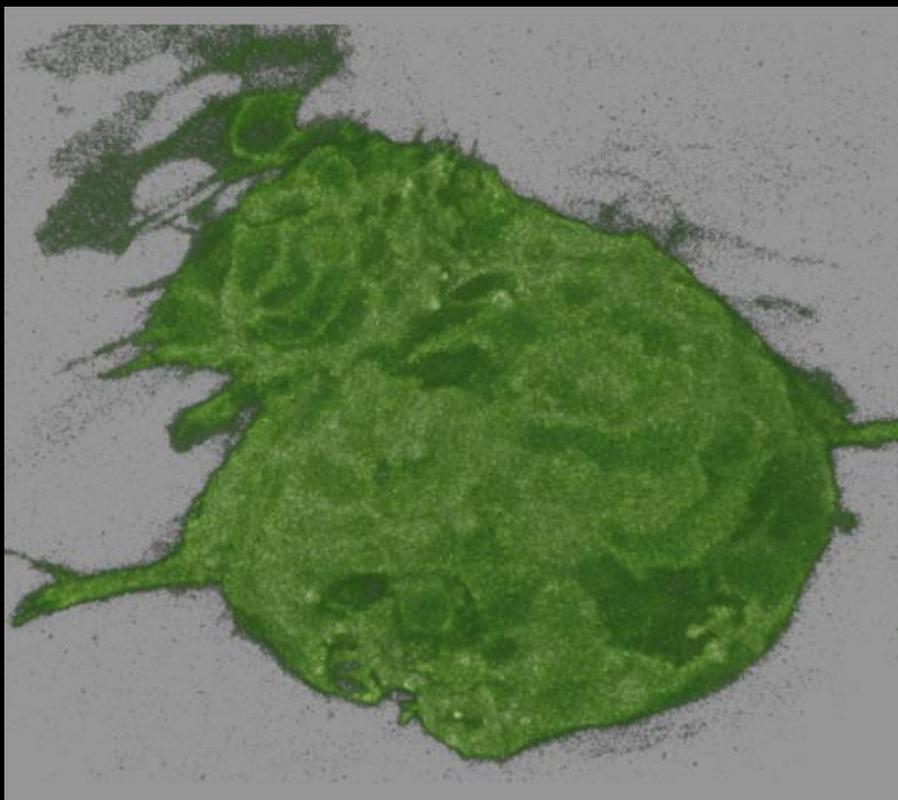
Figure 2.5 System diagram of a confocal epi-fluorescence microscope.

| -> Convolution

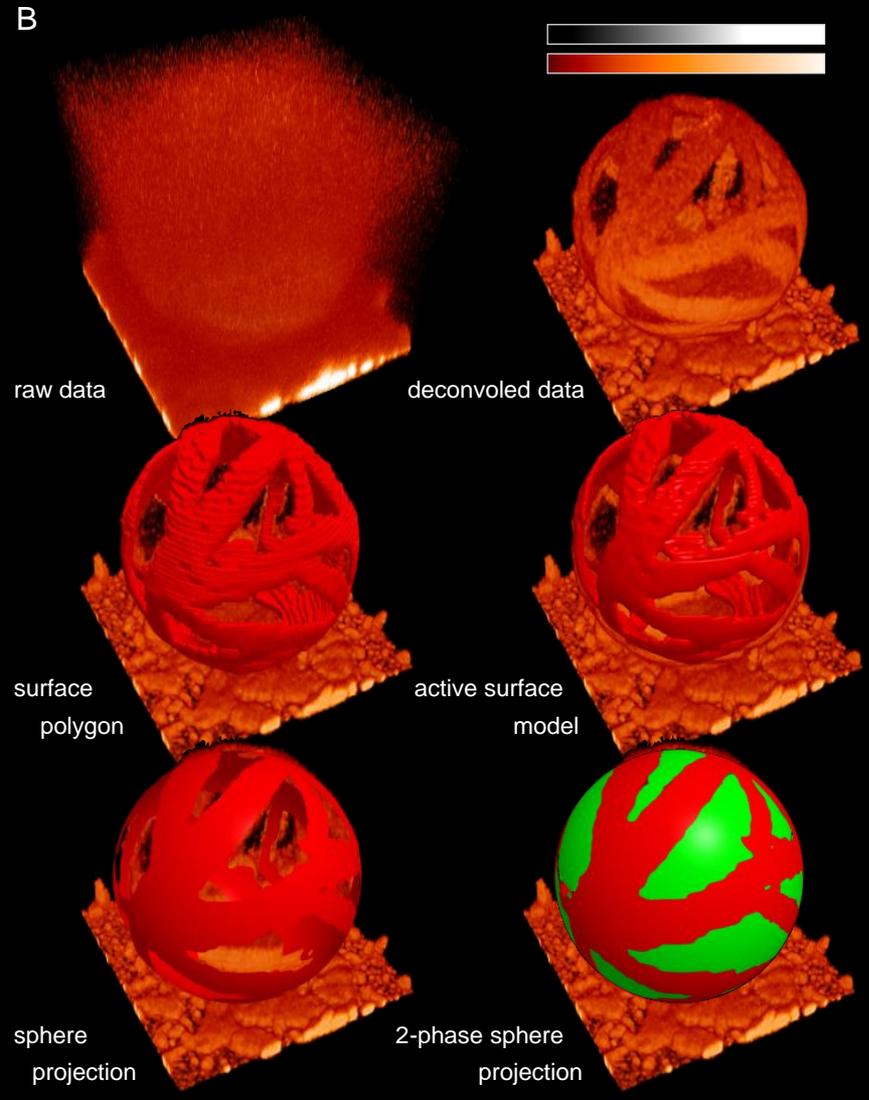
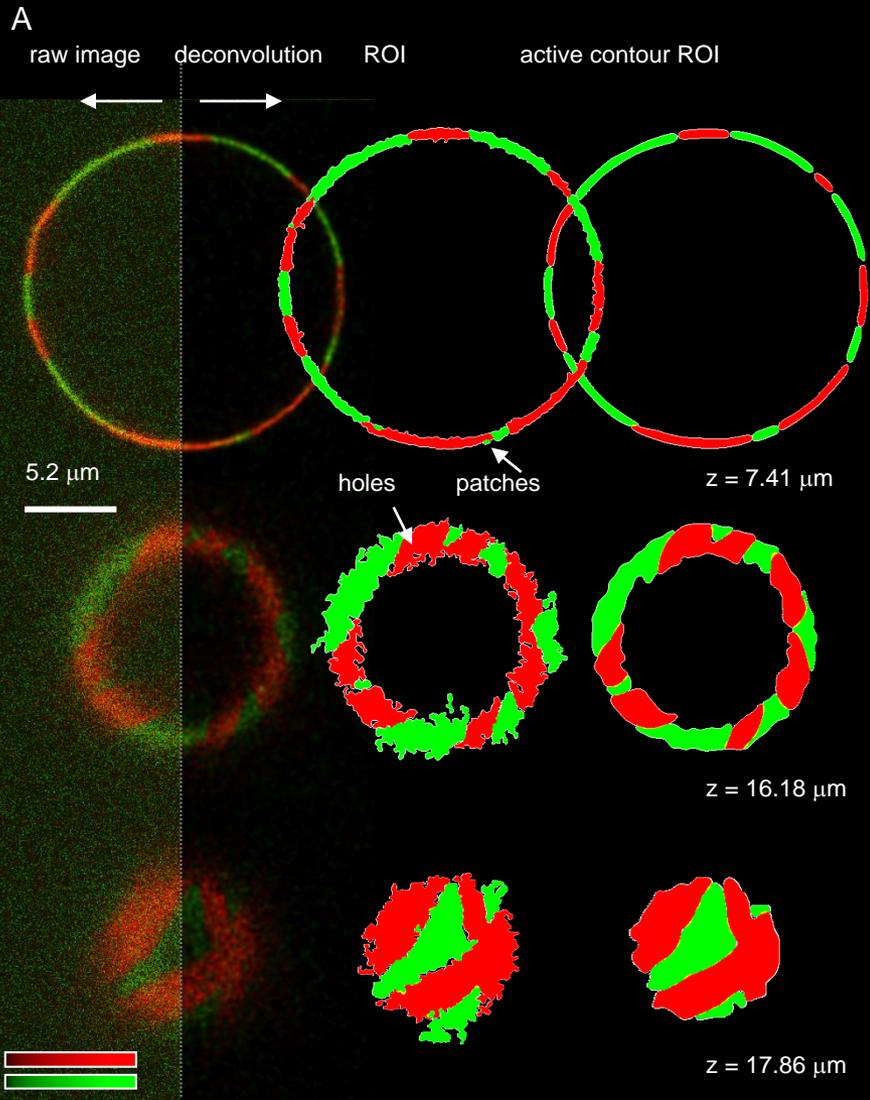


PSF:
 $\Delta xy \sim 500 \text{ nm} \mid \Delta z \sim 1500 \text{ nm}$

| -> Deconvolution



| -> Deconvolution



PSF: Point Spread Function

$$N(\mathbf{PSF}(x, y, z) \otimes \mathbf{f}(x, y, z) + \mathbf{b}(x, y, z)) = \mathbf{I}(x, y, z)$$

f: Object Function

b: Offset Function

I: Image Matrix

N: Noise Function



Calculator

[Numerical aperture](#)

[Excitation wavelength](#)

(nm)

[Emission wavelength](#)

(nm)

[Number of excitation photons](#)

[Backprojected pinhole radius](#)

(nm)

[B.P. distance between pinholes](#)

Only for Nipkow disks (μm)

[Lens medium refractive index](#)

[Specimen medium refractive index](#)

[Acquisition depth](#)

(μm)

Calculate also PSF

- confocal
- widefield
- nipkow
- 4Pi

Select one

PSF: Point Spread Function

f: Object Function

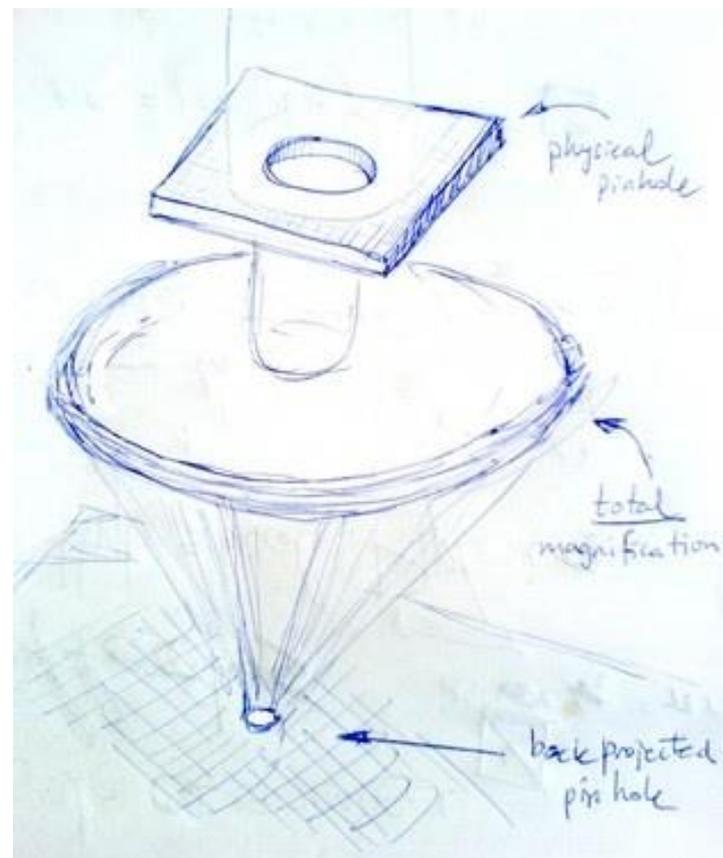
b: Offset Function

I: Image Matrix

N: Noise Function

$$N(\mathbf{PSF}(x, y, z) \otimes \mathbf{f}(x, y, z) + \mathbf{b}(x, y, z)) = \mathbf{I}(x, y, z)$$

**Backprojected
confocal pinhole**



<http://support.svi.nl/wiki/NyquistCalculator>

PSF: Point Spread Function

f: Object Function

b: Offset Function

I: Image Matrix

N: Noise Function

$$N(\mathbf{PSF}(x, y, z) \otimes \mathbf{f}(x, y, z) + \mathbf{b}(x, y, z)) = \mathbf{I}(x, y, z)$$

Biorad

- [Biorad MRC 500, 600 and 1024](#)
- [Biorad Radiance](#)

Leica

- [Leica confocals TCS 4d, SP1 and NT](#)
- [Leica confocal SP2](#)
- [Leica confocal SP5](#)

Nikon

- [TE2000-E with the C1 scanning head](#)

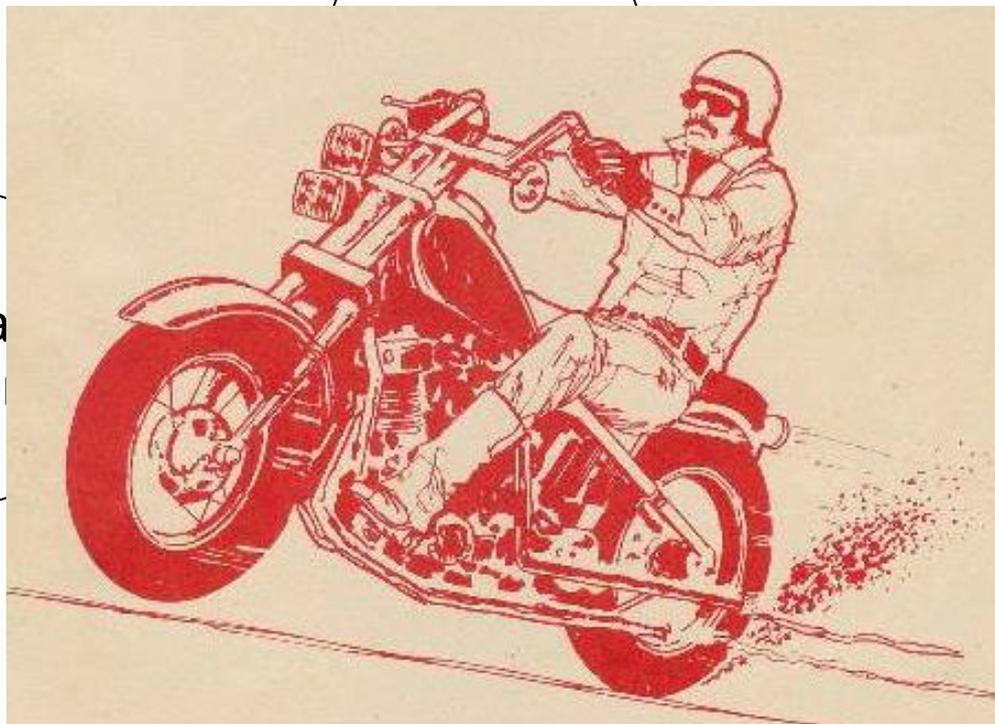
Olympus

- [Olympus FV300](#)
- [Olympus FV500](#)
- [Olympus FV1000](#)

Zeiss

- [Zeiss LSM410 inverted](#)
- [Zeiss LSM510](#)

Informa
Theo



atistical
ysics

Literature: eg. Noise Theory and Application to Physics: Philippe Réfrégier, Springer

PSF: Point Spread Function

f: Object Function

b: Offset Function

I: Image Matrix

N: Noise Function

- Black Body Irradiation
(Poisson)

- Detector Noise
(Gauss)

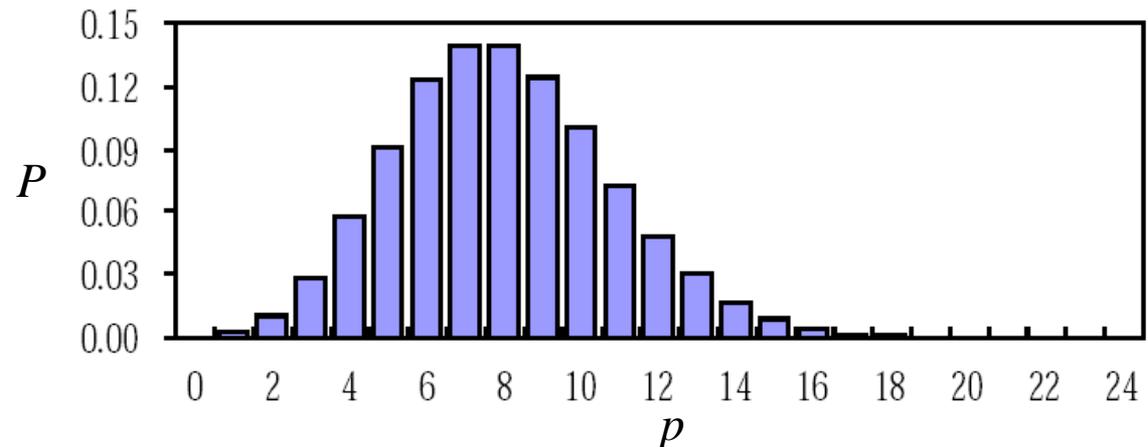
$$\mathbf{N}(\mathbf{PSF}(x, y, z) \otimes \mathbf{f}(x, y, z) + \mathbf{b}(x, y, z)) = \mathbf{I}(x, y, z)$$

$$P(p, \mu) = \frac{\mu^p}{p!} \cdot e^{-\mu}$$

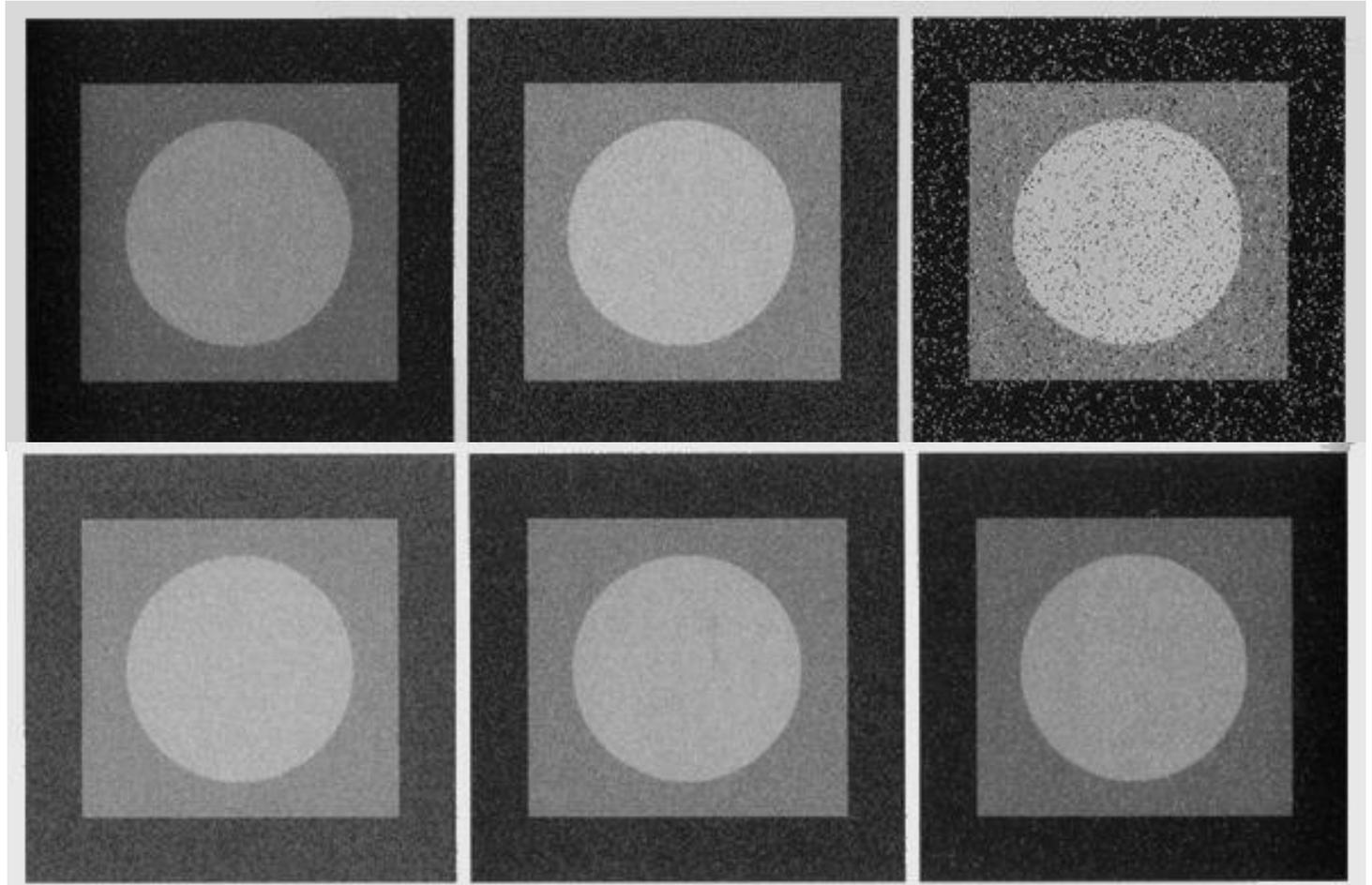
$$1. \bar{p} = \mu = \sigma^2, sd = \sigma = \sqrt{\bar{p}} = \sqrt{\mu}$$

$$2. \text{counting} : \bar{p} \pm \sqrt{\bar{p}}$$

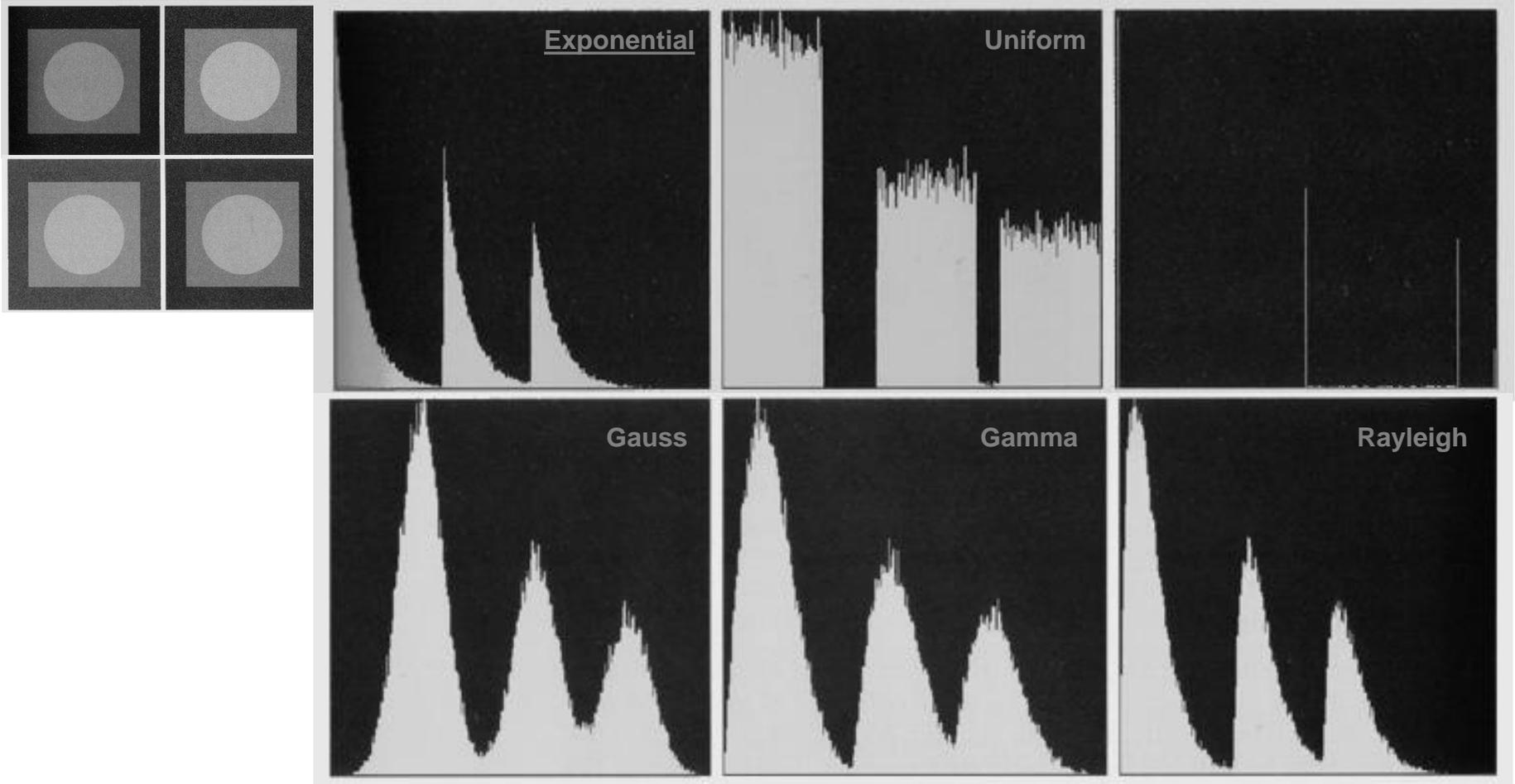
$$3. \text{Poisson}(\text{discrete}) \rightarrow \text{Gauss}(\text{continuous}) : \mu \rightarrow \infty$$



| -> Noise



| -> Noise



The Signal to Noise ratio (SN) is a number not always easy to estimate. The easiest way to obtain some figures is to look at the textures of bright areas in your object image. In the figure at left you see examples of such textures obtained from originally the same object image to which various levels of poisson noise were added.

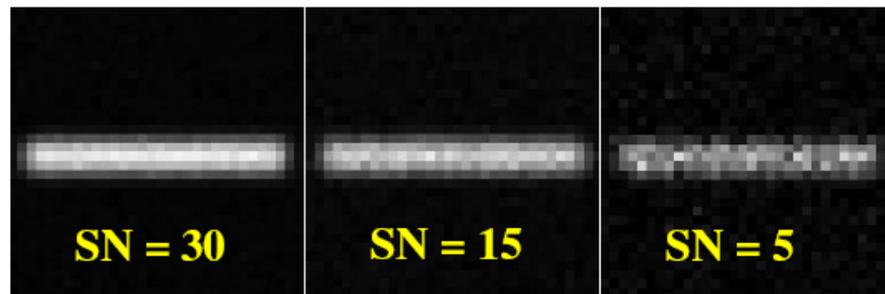
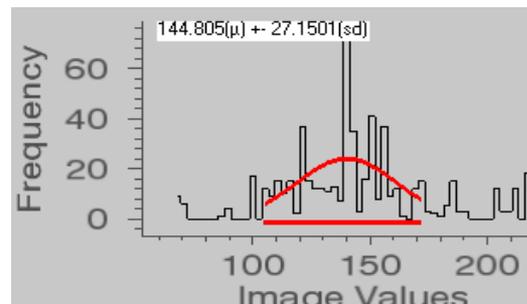
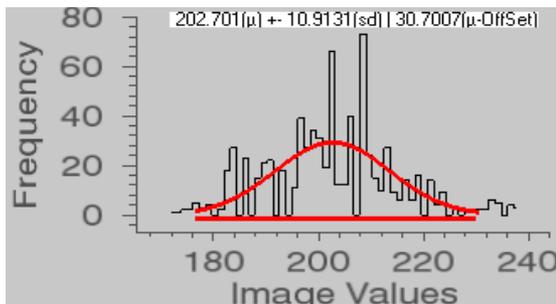
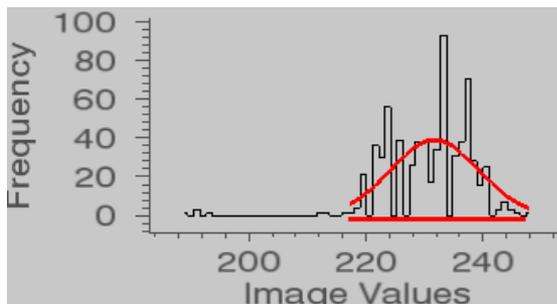


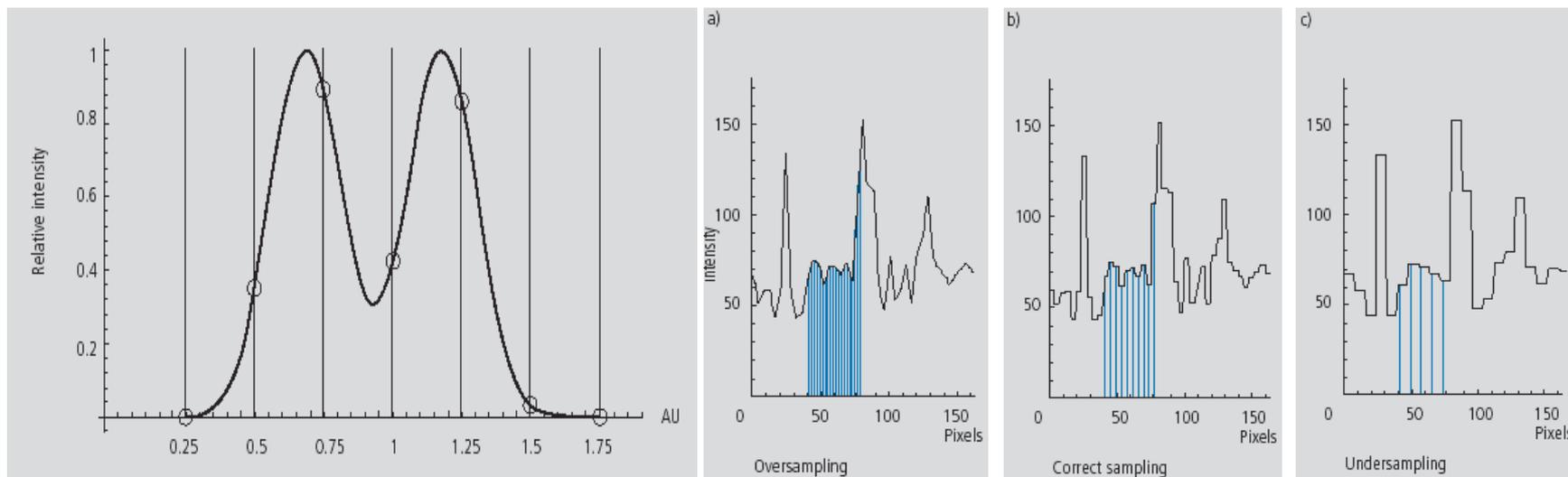
Figure 9. Images with different generated noise levels



$$SNR = \frac{\bar{I}}{\sigma} = \frac{\bar{I}}{\sqrt{\sigma^2}} = \frac{229}{7.5}$$

$$SNR = \frac{\bar{I}}{\sigma} = \frac{\bar{I}}{\sqrt{\sigma^2}} = \frac{200}{10}$$

$$SNR = \frac{\bar{I}}{\sigma} = \frac{\bar{I}}{\sqrt{\sigma^2}} = \frac{139}{27}$$



- Undersampling loses structures.
- Oversampling waists memory/computation time.

The 'Nyquist /Shannon Theorem' or 'Sampling Theorem' for the digital sampling of analogue signals suggests a Nyquist rate $NR \geq 2v$?

! Diffraction theory calculates lateral $NR \sim 20 \text{ pixel}/\mu\text{m} (\sim 50 \text{ nm}/\text{pixel})$!
... axial $NR \sim (\sim 150 \text{ nm}/\text{pixel})$

PSF: Point Spread Function

f: Object Function

b: Offset Function

I: Image Matrix

N: Noise Function

$$N(\text{PSF}(x, y, z) \otimes f(x, y, z) + b(x, y, z)) = I(x, y, z)$$



Calculator

[Numerical aperture](#)

[Excitation wavelength](#)

 (nm)

[Emission wavelength](#)

 (nm)

[Number of excitation photons](#)

[Backprojected pinhole radius](#)

 (nm)

[B.P. distance between pinholes](#)

 Only for Nipkow disks (μm)

[Lens medium refractive index](#)

[Specimen medium refractive index](#)

[Acquisition depth](#)

 (μm)

Calculate also PSF

- confocal
- widefield
- nipkow
- 4Pi

Select one

PSF: Point Spread Function

f: Object Function

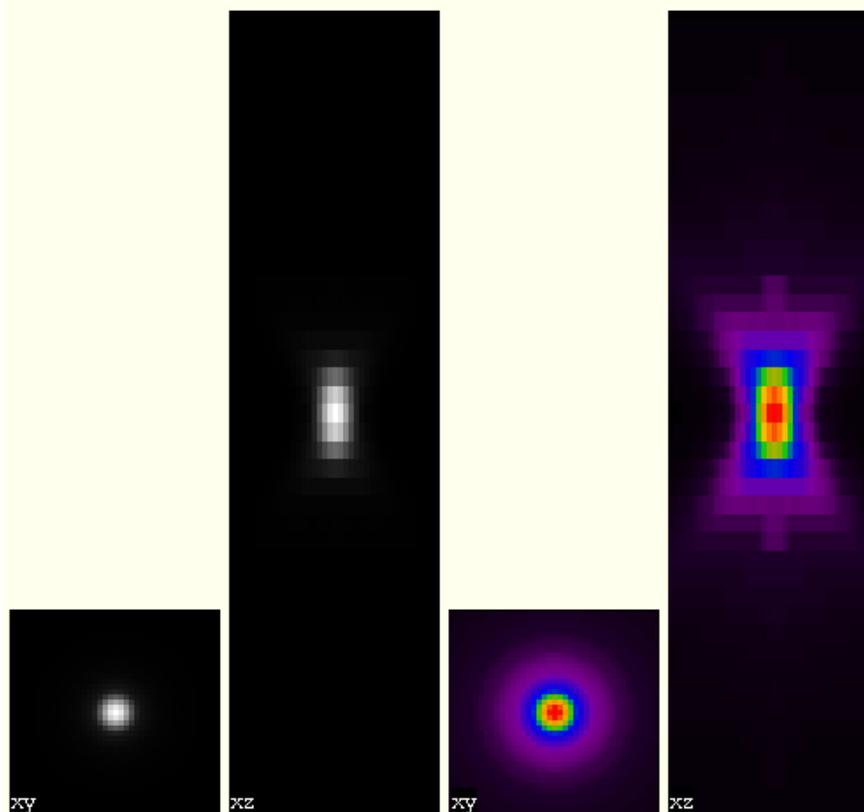
b: Offset Function

I: Image Matrix

N: Noise Function

$$N(\mathbf{PSF}(x, y, z) \otimes \mathbf{f}(x, y, z) + \mathbf{b}(x, y, z)) = \mathbf{I}(x, y, z)$$

[Nyquist sampling](#) (x,y,z in nm): 46, 46, 165



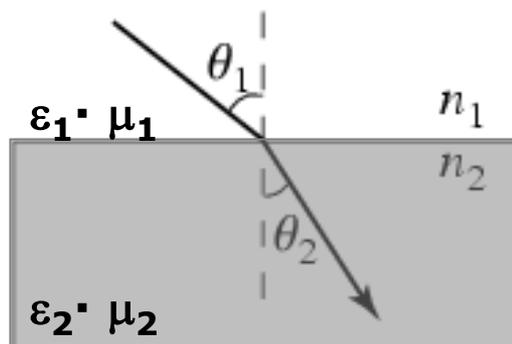
Index of refraction: $n = (\varepsilon \cdot \mu)^{1/2} = c/v$,

ε electric permittivity and μ magnetic permeability.

Snell's Law:

$$\sin \theta_1 n_1 = \sin \theta_2 n_2$$

- 1.518 [Zeiss Oil]
- 1.33 [Water]
- 1.0008 [Air]



Refractive Index:

$$RI = n_1/n_2 = v_2/v_1$$

Snell's Law:

$$\sin \theta_1 n_1 = \sin \theta_2 n_2$$

$$n = n(\lambda) !$$

- **1.518 [Zeiss]**
- **1.33 [Water]**
- **1.0008 [Air]**

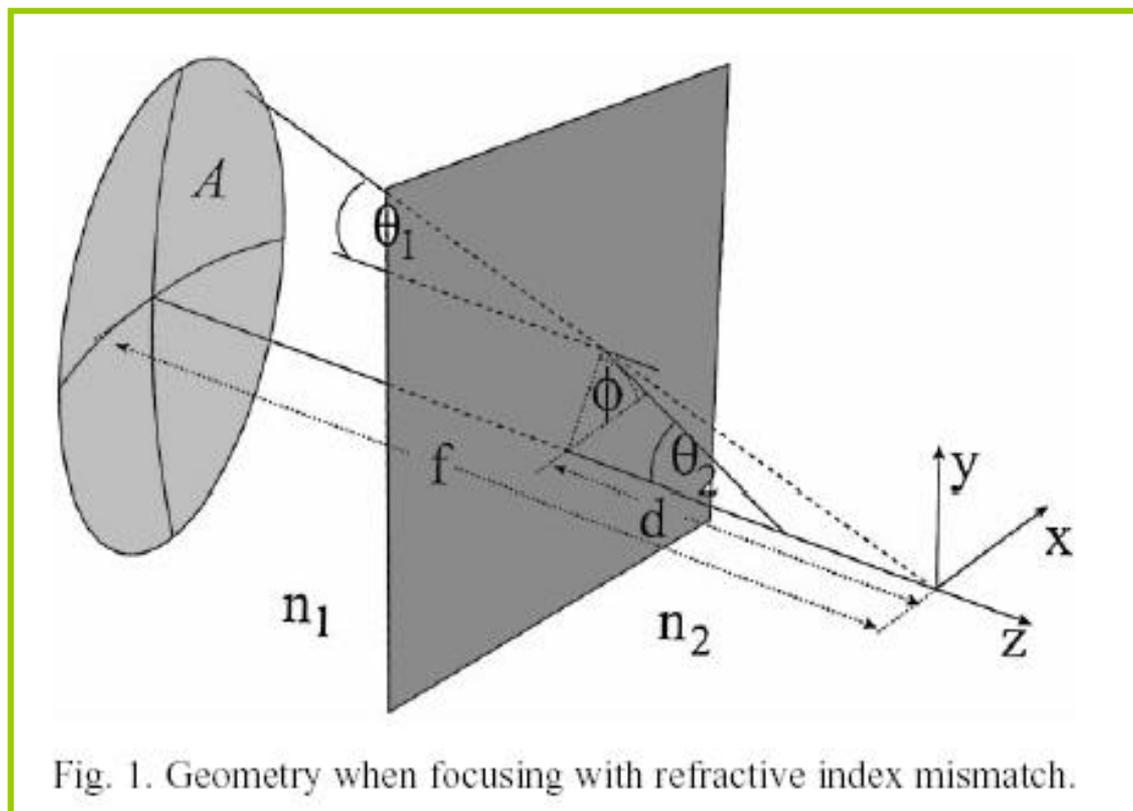
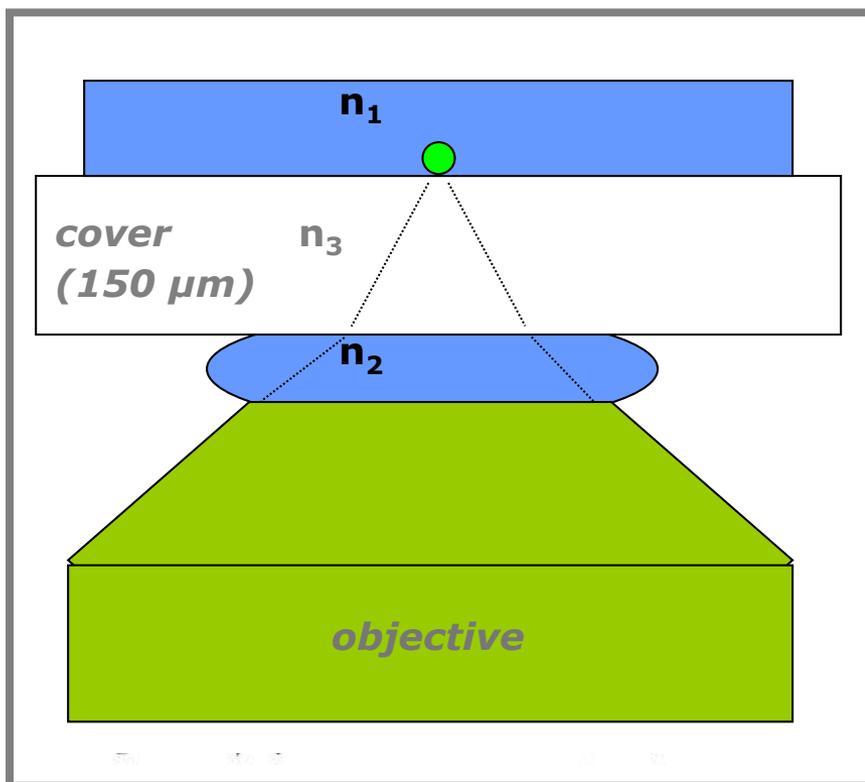


Fig. 1. Geometry when focusing with refractive index mismatch.

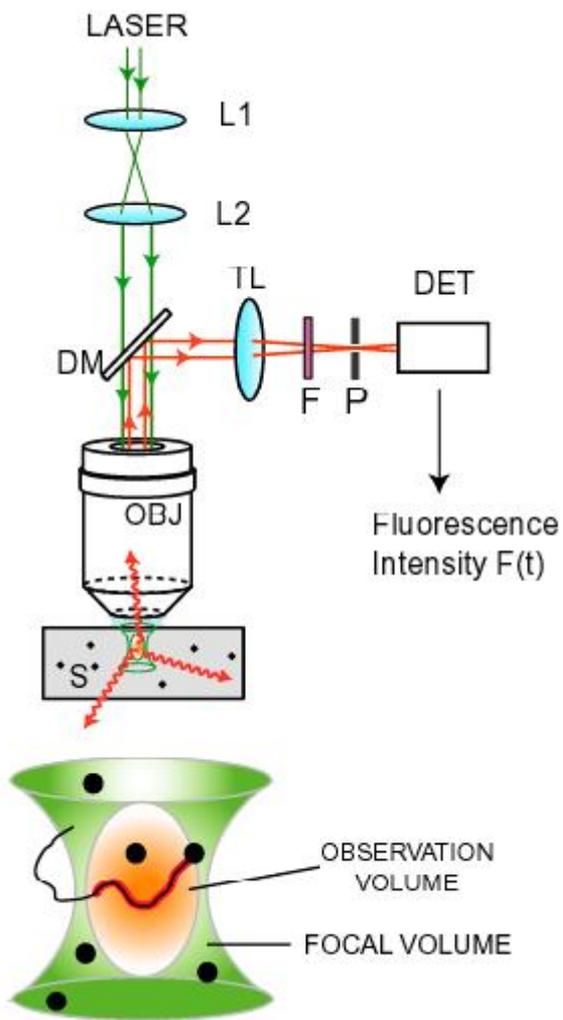
(Egner et al 1998)

● **Micro-esfera:** $\varnothing = 6 \mu\text{m}$



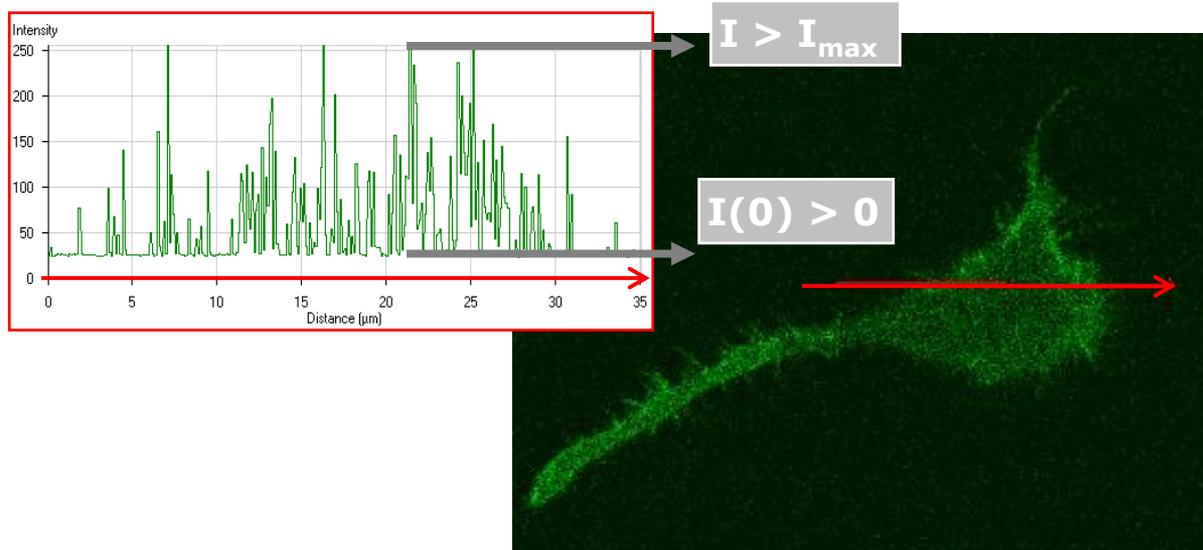
agua/aceite -- *aceite/aceite*
 $n_1 \neq n_2$ $n_1 = n_2$

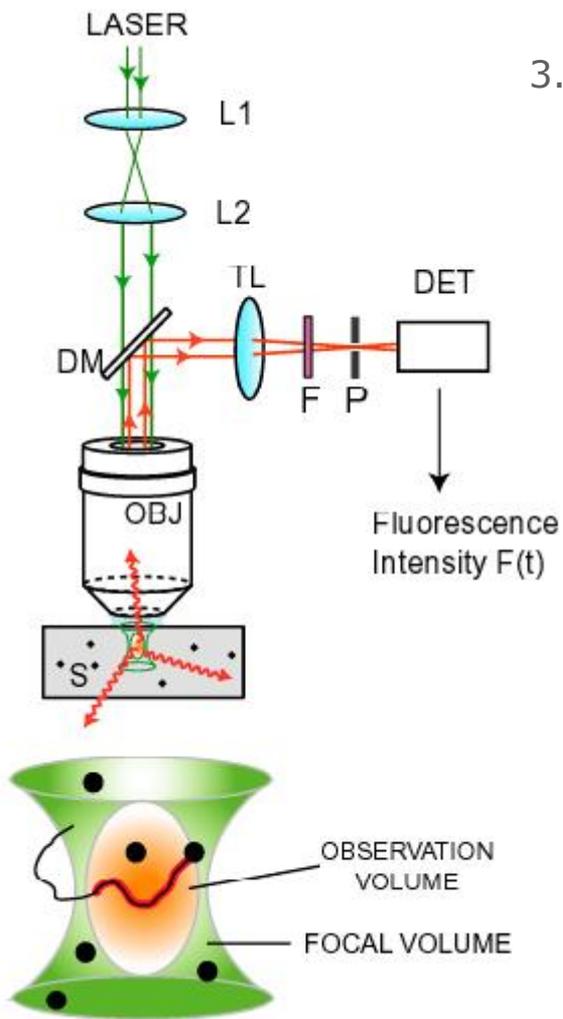
Ley de Snell: $n_i \cdot \sin\theta_i = n_k \cdot \sin\theta_k$
 $n = n(\lambda) !$



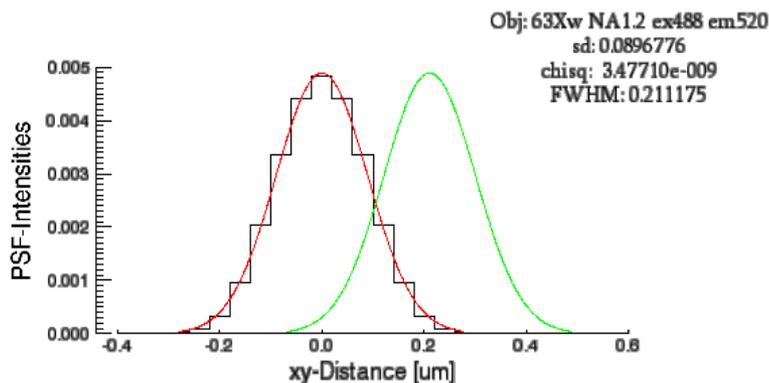
The observation volume (femtoliter) defined by the Point Spread Function must be considered as a mini-spectrofluorimeter.

1. You need to consider the Offset $I(0)$ in order to calibrate your signal $I(0) \geq 0$!
2. Never saturate the signal: $I \leq I_{\max}$ (255 for 8 bit) !

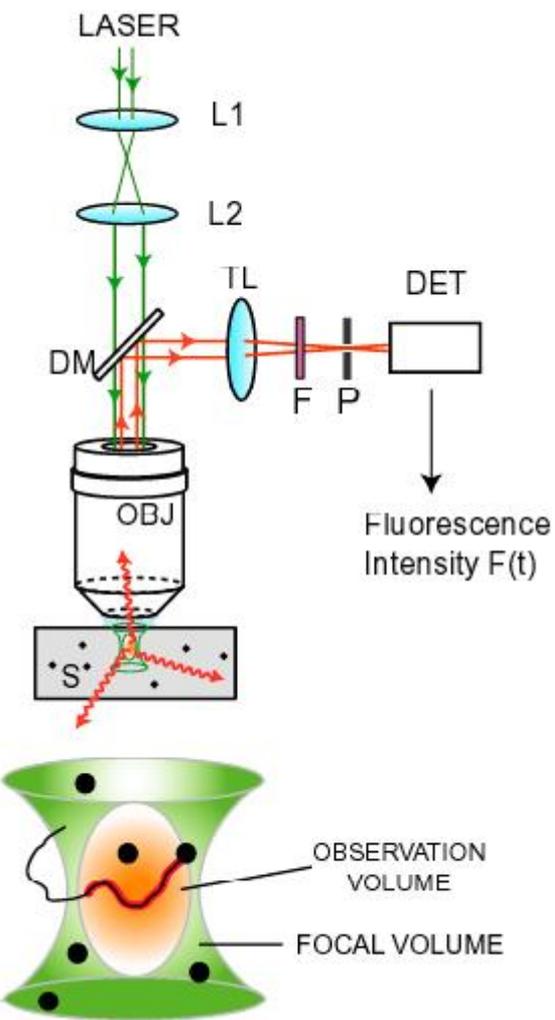




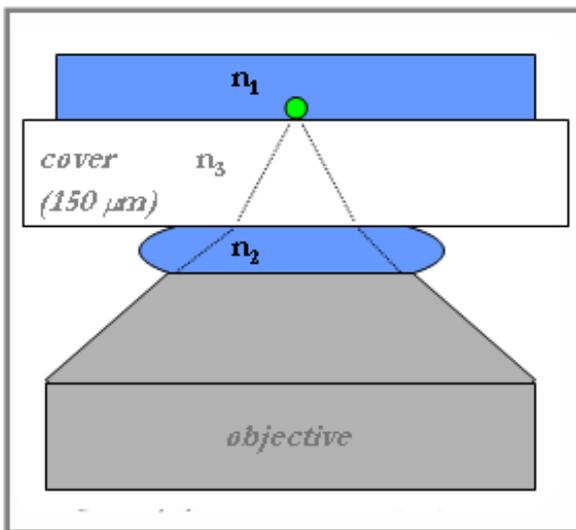
- You need to consider sampling distances in Δx and $\Delta y \approx 50$ nm and $\Delta z \approx 150-300$ nm for later deconvolution, or calculate the explicit sample distances @ <http://support.svi.nl/wiki/NyquistCalculator>



4. Use the right immersion setup !
- $n_1 = n_2$!
- Keep refractive index / index of refraction constant !



● Micro-esfera: $\varnothing = 6 \mu\text{m}$



agua/aceite -- aceite/aceite
 $n_1 \neq n_2$ $n_1 = n_2$
 Ley de Snell: $n_i \cdot \sin\theta_i = n_k \cdot \sin\theta_k$
 $n = n(\lambda)$!